

Search Notes

Application/Control No.

10/749,489

Examiner

Lee, Calvin

Applicant(s)/Patent under
Reexamination

JWA, SEUNG HEE

Art Unit

2818

20063/10020

SEARCHED

Class	Subclass	Date	Examiner
257	301-315	1/31/2005	CL
438	257-267	#	#
#	593, 594	#	#
Updated	Search	6/8/2005	CL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	260	6/9/2005	CL
257	314	#	#

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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2/1/2005

CL